## Notice of References Cited Application/Control No. 10/707,842 Examiner Walter L. Lindsay, Jr. Applicant(s)/Patent Under Reexamination YANG ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,153,501	11-2000	Becker, David S.	438/585
	В	US-6,277,720	08-2001	Doshi et al.	438/586
	C	US-6,198,144	03-2001	Pan et al.	438/592
	D	US-			
	E	US-			
	F	US-		·	
	G	US-			
	Н	US-			
	1	US-	3		
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	·R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	•

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.